

### Description

The FDS8817NZ uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

### **General Features**

 $V_{DS} = 30V I_D = 18A$  $R_{DS(ON)} < 6.5m\Omega @ V_{GS} = 10V$  $R_{DS(ON)} < 12m\Omega @ V_{GS} = 4.5V$ 

### Application

Battery protection

Load switch

Uninterruptible power supply

### Package Marking and Ordering Information

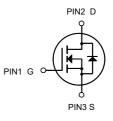
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Product ID	Pack	Brand	Qty(PCS)
FDS8817NZ	SOP-8(SOIC-8)	HXY MOSFET	3000

# Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Limit	Unit
Vds	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±20	V
I <sub>D</sub>	Drain Current-Continuous	18	А
l₀(70 °C)	Drain Current-Continuous(Tc=70°C)	8.2	А
DM	Pulsed Drain Current	42	А
PD	Maximum Power Dissipation	1.5	W
Tj,Tstg	Operating Junction and Storage Temperature Range	-55 To 150	°C
Rejc	Thermal Resistance,Junction-to-Case <sup>(Note 2)</sup>	36	°C <b>/W</b>



SOP-8 (SOIC-8)



N-Channel MOSFET



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	30			V	
$\triangle BV_{\text{DSS}} / \triangle T_{\text{J}}$	BVDSS Temperature Coefficient	Reference to $25^{\circ}$ C , I <sub>D</sub> =1mA		0.027		V/°C	
Rds(on)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V , I <sub>D</sub> =10A		5.5	6.5	mΩ	
TUDS(ON)		$V_{GS}$ =4.5V , $I_{D}$ =8A		9	12	1115.2	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage		1.2	1.5	2.5	V	
$ riangle V_{GS(th)}$	$V_{GS(th)} Temperature Coefficient V_{GS}=V_{DS}, I_D = 250 uA$			-5.8		mV/°C	
IDSS	Drain-Source Leakage Current	$V_{DS}$ =24V , $V_{GS}$ =0V , $T_J$ =25°C			1	uA	
IDSS		$V_{DS}$ =24V , $V_{GS}$ =0V , $T_J$ =55°C			5		
Igss	Gate-Source Leakage Current	$V_{GS}=\pm20V$ , $V_{DS}=0V$			±100	nA	
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =10A		5.8		S	
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		2.2	3.8	Ω	
Qg	Total Gate Charge (4.5V)			12.6	17.6		
Qgs	Gate-Source Charge	V <sub>DS</sub> =15V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =10A		4.2	5.9	nC	
$Q_{gd}$	Gate-Drain Charge			5.1	7.1		
T <sub>d(on)</sub>	Turn-On Delay Time			6.2	12.4		
Tr	Rise Time	V <sub>DD</sub> =15V , V <sub>GS</sub> =10V , R <sub>G</sub> =3.3Ω I <sub>D</sub> =10A		59	106	ns	
T <sub>d(off)</sub>	Turn-Off Delay Time			27.6	55		
T <sub>f</sub>	Fall Time			8.4	16.8		
Ciss	Input Capacitance			1317	1845		
Coss	Output Capacitance	V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz		163	228.2	pF	
Crss	Reverse Transfer Capacitance			131	183.4		
ls	Continuous Source Current <sup>1,5</sup>				10.3	A	
I <sub>SM</sub>	Pulsed Source Current <sup>2,5</sup> V <sub>G</sub> =V <sub>D</sub> =0V , Force Current				42	A	
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C			1.2	V	
trr	Reverse Recovery Time			12.5		nS	
Qrr	Reverse Recovery Charge	IF=10A , dl/dt=100A/µs , Tյ=25°C		5		nC	

### Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Note :

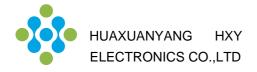
1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width  $\,\leq\,$  300us , duty cycle  $\,\leq\,$  2%

3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =25V,  $V_{GS}$ =10V, L=0.1mH,  $I_{AS}$ =35A

4.The power dissipation is limited by 150°C junction temperature

5.The data is theoretically the same as  $I_{\text{D}}$  and  $I_{\text{DM}}$  , in real applications , should be limited by total power dissipation.



# **Typical Characteristics**

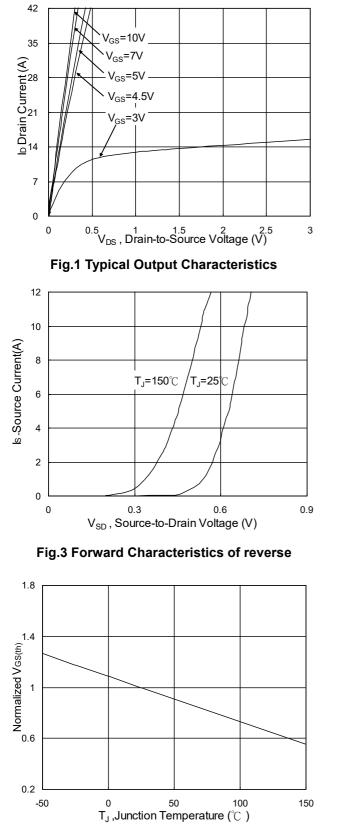


Fig.5 Normalized  $V_{\text{GS}(\text{th})}$  vs.  $T_{\text{J}}$ 

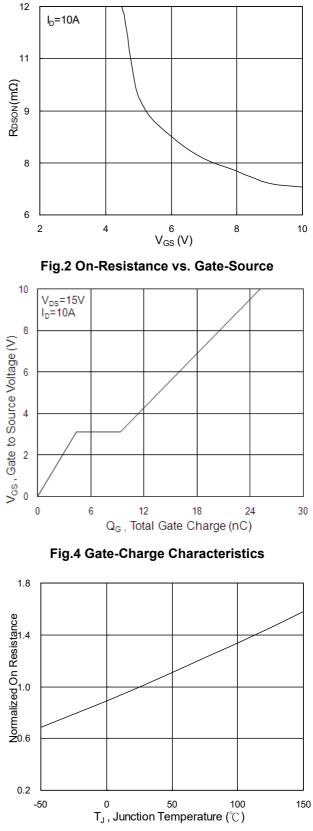
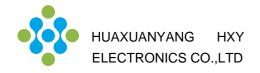


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



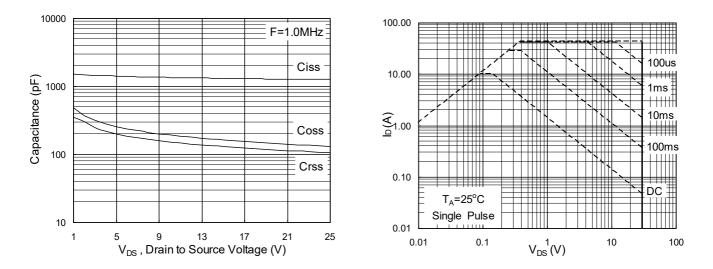
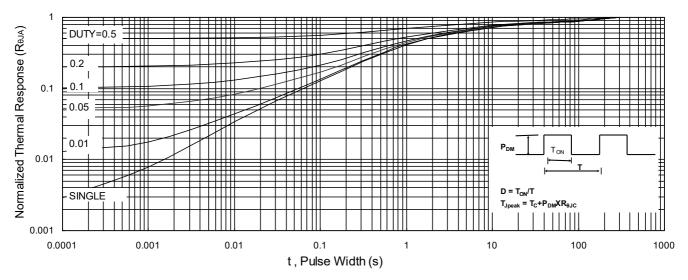


Fig.7 Capacitance

Fig.8 Safe Operating Area





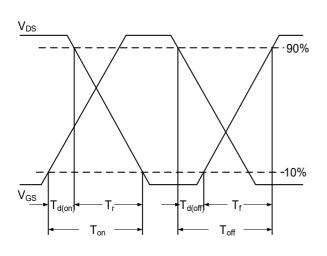


Fig.10 Switching Time Waveform

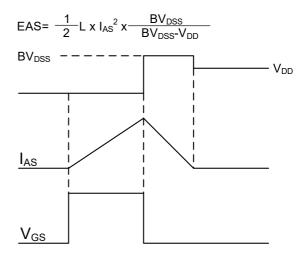
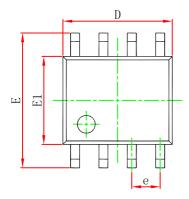
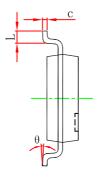


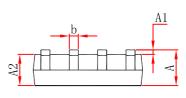
Fig.11 Unclamped Inductive Switching Waveform



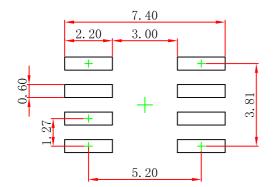
# SOP-8(SOIC-8) Package Outline Dimensions







Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
А	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270 (BSC)		0.050 (BSC)		
E	5.800	6.200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0 °	8°	0 °	8°	



- Note: 1.Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
   3.The pad layout is for reference purposes only.



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